Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/081,673	RAMANATHAN ET AL.	
Examiner	Art Unit	
Jungwon Chang	2154	

	SEAR	CHED	
Class	Subclass	Date	Examiner
709	217	11/17/2005	JWC
709	219	11/17/2005	JMC
709	203	11/17/2005	JWC
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
709	217	11/17/2005	JWC		
709	219	11/17/2005	JMC		
709	203	11/17/2005	JWC		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East text NPL: Google ACM IEEE search report attached	11/17/2005	JWC		